

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
		Examiner William Boddie	Art Unit 2674	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,069,636	05-2000	Sayuda et al.	345/619
	B	US-6,076,734	06-2000	Dougherty et al.	235/462.01
	C	US-6,689,966	02-2004	Wiebe, Linus	345/173
	D	US-5,771,414	06-1998	Bowen, Paul T.	396/312
	E	US-6,791,619	09-2004	Misawa, Takeshi	348/374
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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